

P-CHANNEL MOS FIELD EFFECT POWER TRANSISTOR  
**2SJ329**

**SWITCHING**  
**P-CHANNEL POWER MOS FET**  
**INDUSTRIAL USE**

**DESCRIPTION**

The 2SJ329 is P-channel MOS Field Effect Transistor designed for solenoid, motor and lamp driver.

**FEATURES**

- Low On-state Resistance  
 $R_{DS(on)} = 47 \text{ m}\Omega \text{ TYP. (} V_{GS} = -10 \text{ V, } I_D = -8 \text{ A)}$   
 $R_{DS(on)} = 80 \text{ m}\Omega \text{ TYP. (} V_{GS} = -4 \text{ V, } I_D = -6 \text{ A)}$
- Low  $C_{iss}$        $C_{iss} = 2 \text{ 150 pF TYP.}$
- Built-in G-S Gate Protection Diodes

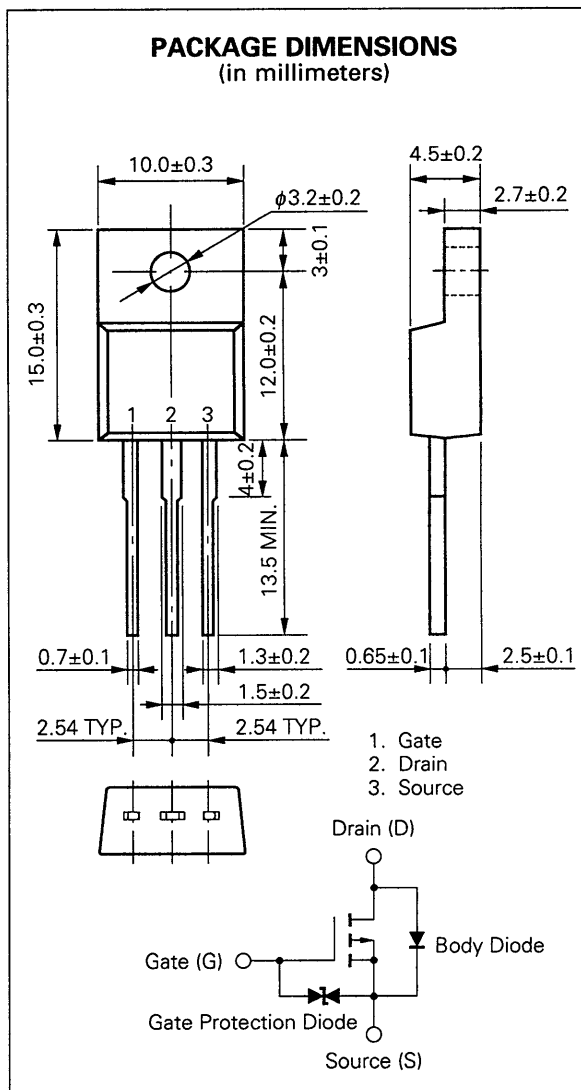
**QUALITY GRADE**

Standard  
 Please refer to "Quality grade on NEC Semiconductor Devices" (Document number IEI-1209) published by NEC Corporation to know the specification of quality grade on the devices and its recommended applications.

**ABSOLUTE MAXIMUM RATINGS ( $T_a = 25 \text{ }^\circ\text{C}$ )**

|   |                  |             |                       |
|---|------------------|-------------|-----------------------|
| Drain to Source Voltage                                       | $V_{DSS}$        | -60         | V                     |
| Gate to Source Voltage  | $V_{GSS(AC)}$    | $\pm 20$    | V                     |
| Gate to Source Voltage  | $V_{GSS(DC)}$    | -20, +10    | V                     |
| Drain Current (DC)  | $I_{D(DC)}$      | $\pm 15$    | A                     |
| Drain Current (pulse)   | $I_{D(pulse)^*}$ | $\pm 60$    | A                     |
| Total Power Dissipation ( $T_c = 25 \text{ }^\circ\text{C}$ ) | $P_{T1}$         | 35          | W                     |
| Total Power Dissipation ( $T_a = 25 \text{ }^\circ\text{C}$ ) | $P_{T2}$         | 2.0         | W                     |
| Channel Temperature   | $T_{ch}$         | 150         | $^\circ\text{C MAX.}$ |
| Storage Temperature   | $T_{stg}$        | -55 to +150 | $^\circ\text{C}$      |

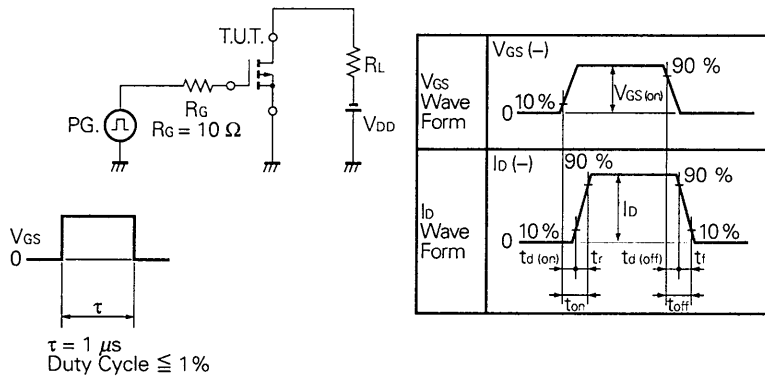
\*  $PW \leq 10 \mu\text{s}$ , Duty Cycle  $\leq 1 \%$



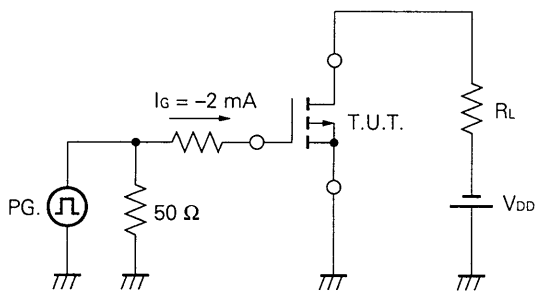
**ELECTRICAL CHARACTERISTICS (T<sub>a</sub> = 25 °C)**

| CHARACTERISTIC                      | SYMBOL               | MIN. | TYP.  | MAX. | UNIT | TEST CONDITIONS  |
|-------------------------------------|----------------------|------|-------|------|------|--|
| Drain to Source On-state Resistance | R <sub>DS(on)</sub>  |      | 47    | 60   | mΩ   | V <sub>GS</sub> = -10 V, I <sub>D</sub> = -8 A   |
| Drain to Source On-state Resistance | R <sub>DS(on)</sub>  |      | 80    | 110  | mΩ   | V <sub>GS</sub> = -4 V, I <sub>D</sub> = -6 A  |
| Gate to Source Cutoff Voltage       | V <sub>GS(off)</sub> | -1.0 | -1.5  | -2.0 | V    | V <sub>DS</sub> = -10 V, I <sub>D</sub> = -1 mA  |
| Forward Transfer Admittance         | y <sub>fs</sub>      | 8.0  | 12    |      | S    | V <sub>DS</sub> = -10 V, I <sub>D</sub> = -8 A   |
| Drain Leakage Current               | I <sub>DSS</sub>     |      |       | -10  | μA   | V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0   |
| Gate to Source Leakage Current      | I <sub>GSS</sub>     |      |       | ±10  | μA   | V <sub>GS</sub> = ±16 V, V <sub>DS</sub> = 0   |
| Input Capacitance                   | C <sub>iss</sub>     |      | 2 150 |      | pF   | V <sub>DS</sub> = -10 V  |
| Output Capacitance                  | C <sub>oss</sub>     |      | 1 100 |      | pF   | V <sub>GS</sub> = 0  |
| Reverse Transfer Capacitance        | C <sub>rss</sub>     |      | 530   |      | pF   | f = 1 MHz  |
| Turn-On Delay Time                  | t <sub>d(on)</sub>   |      | 35    |      | ns   | V <sub>GS(on)</sub> = -10 V<br>V <sub>DD</sub> = -30 V<br>I <sub>D</sub> = -8 A, R <sub>G</sub> = 10 Ω<br>R <sub>L</sub> = 3.8 Ω |
| Rise Time                           | t <sub>r</sub>       |      | 150   |      | ns   |  |
| Turn-Off Delay Time                 | t <sub>d(off)</sub>  |      | 260   |      | ns   |  |
| Fall Time                           | t <sub>f</sub>       |      | 230   |      | ns   |  |
| Total Gate Charge                   | Q <sub>G</sub>       |      | 80    |      | nC   | V <sub>GS</sub> = -10 V<br>I <sub>D</sub> = -15 A<br>V <sub>DD</sub> = -48 V   |
| Gate to Source Charge               | Q <sub>GS</sub>      |      | 6     |      | nC   |  |
| Gate to Drain Charge                | Q <sub>GD</sub>      |      | 35    |      | nC   |  |
| Diode Forward Voltage               | V <sub>SD</sub>      |      | 1.0   |      | V    | I <sub>F</sub> = 15 A, V <sub>GS</sub> = 0   |
| Reverse Recovery Time               | t <sub>rr</sub>      |      | 120   |      | ns   | I <sub>F</sub> = 15 A, V <sub>GS</sub> = 0   |
| Reverse Recovery Charge             | Q <sub>rr</sub>      |      | 260   |      | nC   | di/dt = 50 A/μs  |

**Test Circuit 1: Switching Time**

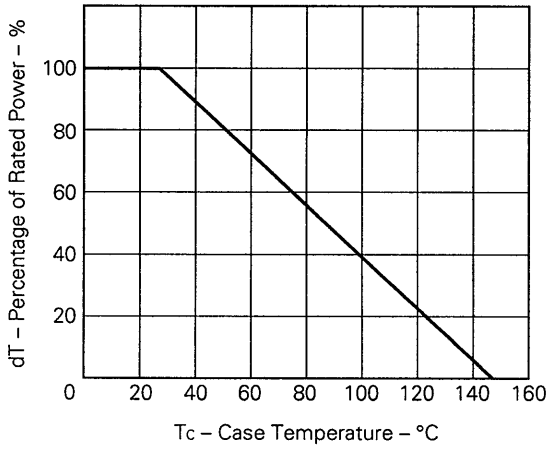


**Test Circuit 2: Gate Charge**

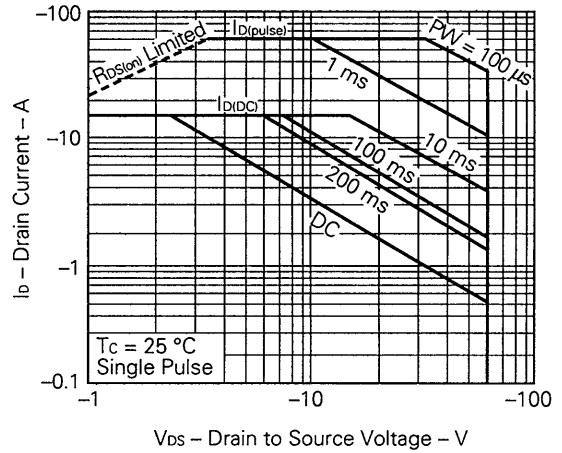


ELECTRICAL CHARACTERISTICS (T<sub>a</sub> = 25 °C)

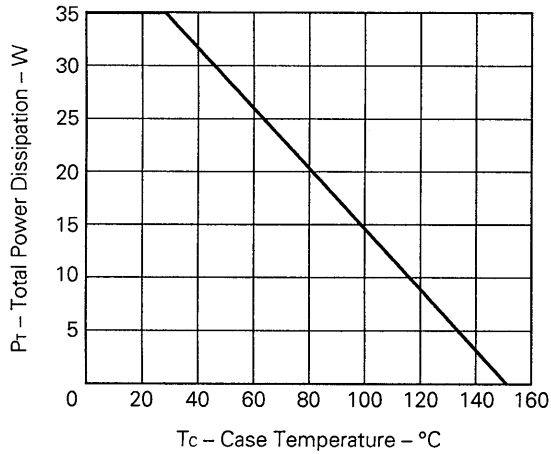
DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



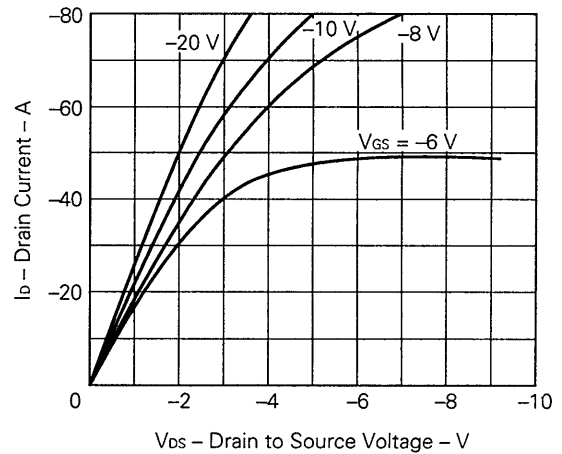
FORWARD BIAS SAFE OPERATING AREA



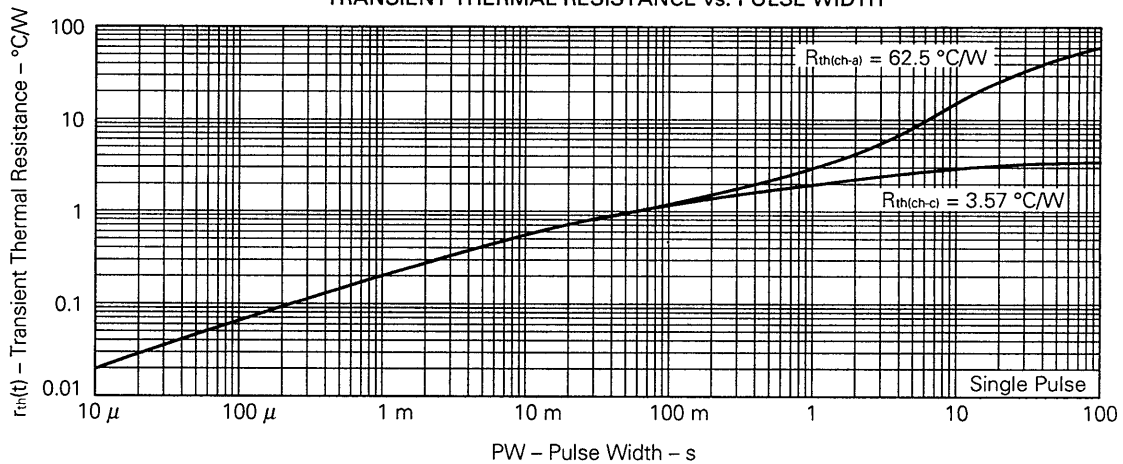
TOTAL POWER DISSIPATION vs. CASE TEMPERATURE



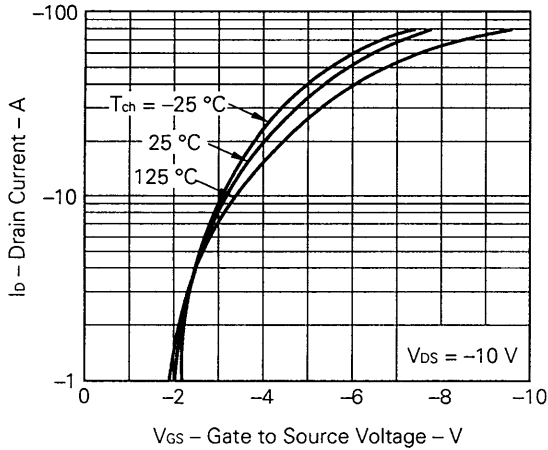
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



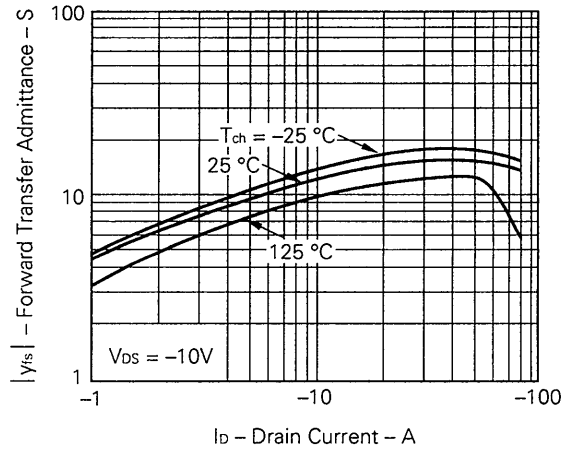
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



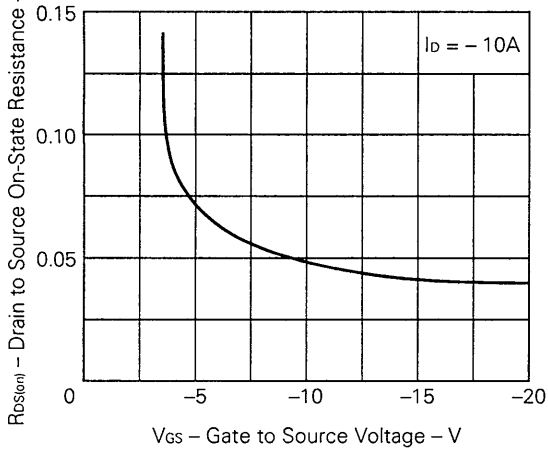
TRANSFER CHARACTERISTICS



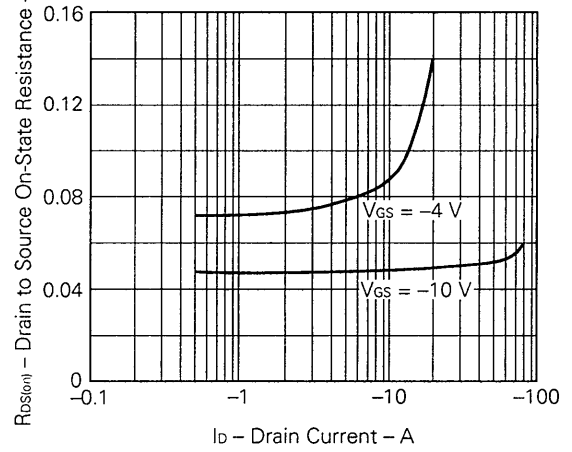
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



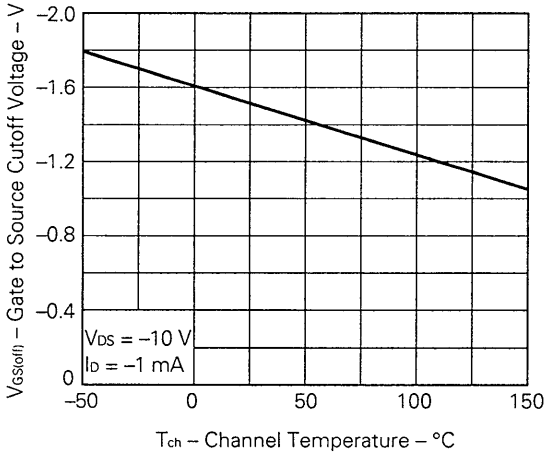
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



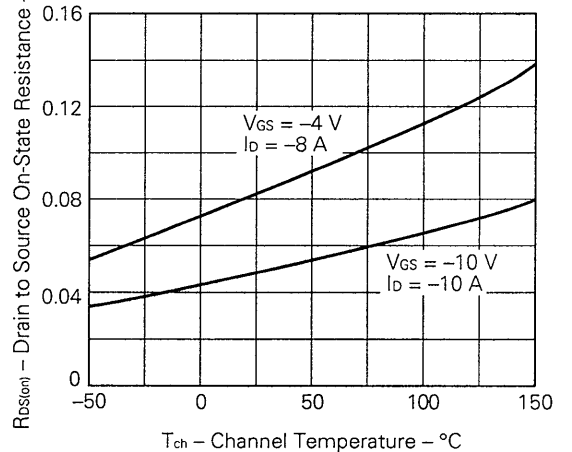
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

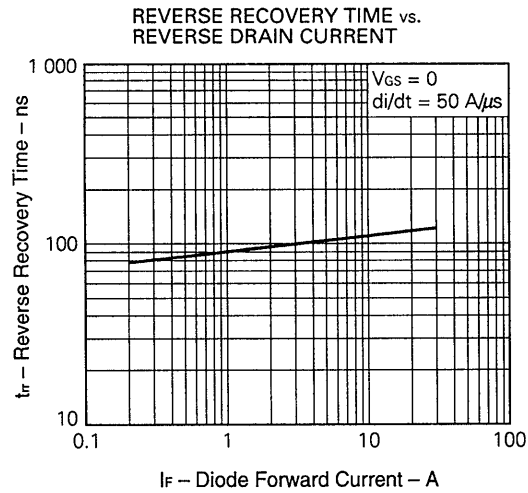
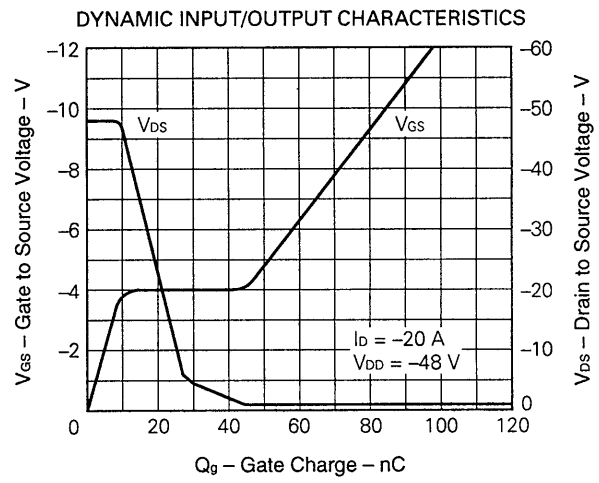
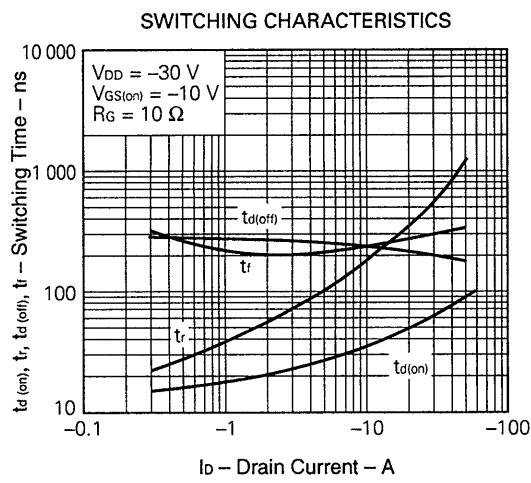
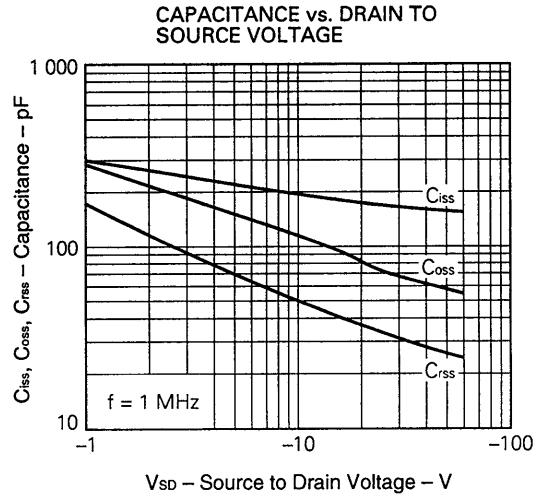
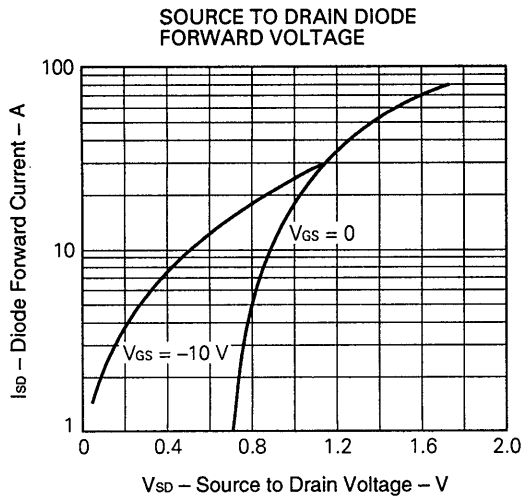


GATE TO SOURCE CUTOFF VOLTAGE vs. CHANNEL TEMPERATURE



DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE





**Reference**

| Application note name                            | No.      |
|--|----------|
| Safe operating area of Power MOS FET.            | TEA-1034 |
| Application circuit using Power MOS FET.         | TEA-1035 |
| Quality control of NEC semiconductors devices.   | TEI-1202 |
| Quality control guide of semiconductors devices. | MEI-1202 |
| Assembly manual of semiconductors devices.       | IEI-1207 |

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